Notice of References Cited	Application/Control No. 10/542,002	Applicant(s)/Patent Under Reexamination TOGANO ET AL.		
	Examiner	Art Unit	Page 1 of 1	
	YUK CHOW	2629		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0048521 A1	03-2003	Ikeda et al.	359/296
*	В	US-6,639,580 B1	10-2003	Kishi et al.	345/107
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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